1 Features

- Up and Down Translation across 1.65 V to 3.6 V
- Operating Temperature: −40°C to +125°C
- Maximum Quiescent Current ($I_{CCA} + I_{CCB}$) of 14 $\mu$A (125°C Maximum)
- Up to 100 Mbps support across the full supply range
- $V_{CC}$ Isolation Feature
  - If Either $V_{CC}$ Input is Below 100 mV, the output becomes High-Impedance
- $I_{off}$ Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human Body Model
  - 1000-V Charged-Device Model

2 Applications

- MCU/FPGA/Processor GPIO Translation
- Communications Modules to Processor Translation
- Push-Pull I/O Buffering

3 Description

The 2N7001T is a single-bit buffered voltage signal converter that uses two separate configurable power-supply rails to up or down translate a unidirectional signal. The device is operational with both $V_{CCA}$ and $V_{CCB}$ supplies down to 1.65 V and up to 3.60 V. $V_{CCA}$ defines the input threshold voltage on the A input. $V_{CCB}$ defines the output drive voltage on the B output.

This device is fully specified for partial-power-down applications using the $I_{off}$ current. The $I_{off}$ protection circuitry ensures that no excessive current is drawn from or to an input, output, or combined I/O that is biased to a specific voltage while the device is powered down.

The $V_{CC}$ isolation feature ensures that if either $V_{CCA}$ or $V_{CCB}$ is less than 100 mV, the output port (B) enters a high-impedance state.

Device Information

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>PACKAGE</th>
<th>BODY SIZE (NOM)</th>
</tr>
</thead>
<tbody>
<tr>
<td>2N7001TDCK</td>
<td>SC70 (5)</td>
<td>2.00 mm × 1.25 mm</td>
</tr>
<tr>
<td>2N7001TDPW</td>
<td>X2SON (5)</td>
<td>0.80 mm × 0.80 mm</td>
</tr>
</tbody>
</table>

(1) For all available packages, see the orderable addendum at the end of the data sheet.
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4 Revision History
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (May 2018) to Revision A

- Changed from Advanced Information to Production Data ........................................... 1

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### 5 Pin Configuration and Functions

#### Pin Functions

<table>
<thead>
<tr>
<th>PIN</th>
<th>TYPE</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>I</td>
<td>Data Input. This pin is referenced to $V_{CCA}$.</td>
</tr>
<tr>
<td>B</td>
<td>O</td>
<td>Data Output. This pin is referenced to $V_{CCB}$.</td>
</tr>
<tr>
<td>$V_{CCA}$</td>
<td></td>
<td>Input Supply voltage. $1.65V \leq V_{CCA} \leq 3.6V$.</td>
</tr>
<tr>
<td>$V_{CCB}$</td>
<td></td>
<td>Output Supply voltage. $1.65V \leq V_{CCB} \leq 3.6V$.</td>
</tr>
<tr>
<td>GND</td>
<td>—</td>
<td>Ground</td>
</tr>
</tbody>
</table>
6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)\(^{(1)}\)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(V_{CCA})</td>
<td>–0.5</td>
<td>4.2</td>
<td>V</td>
</tr>
<tr>
<td>(V_{CGB})</td>
<td>–0.5</td>
<td>4.2</td>
<td>V</td>
</tr>
<tr>
<td>(V_{I})</td>
<td>–0.5</td>
<td>4.2</td>
<td>V</td>
</tr>
<tr>
<td>(V_{O})</td>
<td>–0.5</td>
<td>4.2</td>
<td>V</td>
</tr>
<tr>
<td>(I_{IK})</td>
<td>(V_{I} &lt; 0)</td>
<td>–50</td>
<td>mA</td>
</tr>
<tr>
<td>(I_{OK})</td>
<td>(V_{O} &lt; 0)</td>
<td>–50</td>
<td>mA</td>
</tr>
<tr>
<td>(I_{O})</td>
<td>–50</td>
<td>50</td>
<td>mA</td>
</tr>
<tr>
<td>(I_{O})</td>
<td>–10</td>
<td>10</td>
<td>mA</td>
</tr>
<tr>
<td>(T_{J})</td>
<td>–40</td>
<td>150</td>
<td>°C</td>
</tr>
<tr>
<td>(T_{stg})</td>
<td>–65</td>
<td>150</td>
<td>°C</td>
</tr>
</tbody>
</table>

(1) Stresses beyond those listed under the Absolute Maximum Ratings table may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The output positive-voltage rating may be exceeded up to 4.2 V maximum if the output current ratings are observed.

6.2 ESD Ratings

<table>
<thead>
<tr>
<th>Parameter</th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(V_{ESD})</td>
<td>Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001(^{(1)})</td>
<td>±2000</td>
</tr>
<tr>
<td></td>
<td>Charged-device model (CDM), per JEDEC specification JESD22-C101(^{(2)})</td>
<td>±1000</td>
</tr>
</tbody>
</table>

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
6.3 Recommended Operating Conditions
over operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>THERMAL METRIC</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( V_{CCA} ) Supply voltage, ( V_{CCB} )</td>
<td>1.65</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>( V_{IH} ) High-level input voltage</td>
<td>( V_{CCA} = 1.65 \text{ V} - 1.95 \text{ V} )</td>
<td>( V_{CCA} \times 0.65 )</td>
<td>V</td>
</tr>
<tr>
<td>( V_{IL} ) Low-level input voltage</td>
<td>( V_{CCA} = 1.65 \text{ V} - 1.95 \text{ V} )</td>
<td>( V_{CCA} \times 0.65 )</td>
<td>V</td>
</tr>
<tr>
<td>( V_{I} ) Input voltage</td>
<td>0</td>
<td>3.6</td>
<td>V</td>
</tr>
<tr>
<td>( V_{O} ) Output voltage</td>
<td>( V_{CCA} \times 0.65 )</td>
<td>( V_{CCA} \times 0.65 )</td>
<td>V</td>
</tr>
<tr>
<td>( \Delta T/\Delta V ) Input transition rise or fall rate</td>
<td>100</td>
<td>100</td>
<td>ns/V</td>
</tr>
<tr>
<td>( T_{A} ) Operating free-air temperature</td>
<td>–40</td>
<td>125</td>
<td>°C</td>
</tr>
</tbody>
</table>

6.4 Thermal Information

<table>
<thead>
<tr>
<th>THERMAL METRIC(^{(1)})</th>
<th>2N7001T</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>DCK (SC70)</td>
</tr>
<tr>
<td></td>
<td>5 PINS</td>
</tr>
<tr>
<td>( R_{JUA} ) Junction-to-ambient thermal resistance</td>
<td>253.5</td>
</tr>
<tr>
<td>( R_{JUC(top)} ) Junction-to-case (top) thermal resistance</td>
<td>162.6</td>
</tr>
<tr>
<td>( R_{JUB} ) Junction-to-board thermal resistance</td>
<td>140.6</td>
</tr>
<tr>
<td>( \psi_{JT} ) Junction-to-top characterization parameter</td>
<td>69.8</td>
</tr>
<tr>
<td>( \psi_{JB} ) Junction-to-board characterization parameter</td>
<td>139.7</td>
</tr>
</tbody>
</table>

\(^{(1)}\) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.5 Electrical Characteristics

Over recommended operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>$V_{CCA}$</th>
<th>$V_{CCB}$</th>
<th>MIN</th>
<th>TYP(1)</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{OH}$ High-level</td>
<td>$V_I = V_H$</td>
<td>$I_{OH} = -100 \mu A$</td>
<td>$1.65 \text{ V} - 3.6 \text{ V}$</td>
<td>$V_{CCB}$</td>
<td>$-0.1$</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OH} = -8 \text{ mA}$</td>
<td>$1.65 \text{ V}$</td>
<td>$1.65 \text{ V}$</td>
<td>$1.2$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OH} = -9 \text{ mA}$</td>
<td>$2.3 \text{ V}$</td>
<td>$2.3 \text{ V}$</td>
<td>$1.75$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OH} = -12 \text{ mA}$</td>
<td>$3 \text{ V}$</td>
<td>$3 \text{ V}$</td>
<td>$2.3$</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{OL}$ Low-level</td>
<td>$V_I = V_L$</td>
<td>$I_{OL} = 100 \mu A$</td>
<td>$1.65 \text{ V} - 3.6 \text{ V}$</td>
<td>$V_{CCB}$</td>
<td>$-0.1$</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OL} = 8 \text{ mA}$</td>
<td>$1.65 \text{ V}$</td>
<td>$1.65 \text{ V}$</td>
<td>$0.45$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OL} = 9 \text{ mA}$</td>
<td>$2.3 \text{ V}$</td>
<td>$2.3 \text{ V}$</td>
<td>$0.55$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{OL} = 12 \text{ mA}$</td>
<td>$3 \text{ V}$</td>
<td>$3 \text{ V}$</td>
<td>$0.7$</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{PD}$ Partial power</td>
<td>$V_O = 0 \text{ V} - 3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$0 \text{ V} - 3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$-8 \mu A$</td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td></td>
<td>$V_O = 0 \text{ V} - 3.6 \text{ V}$</td>
<td>$0 \text{ V} - 3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$-8 \mu A$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCA}$ or GND, $I_O = 0 \text{ mA}$</td>
<td>$0 \text{ V}$</td>
<td>$3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCB}$ or GND, $I_O = 0 \text{ mA}$</td>
<td>$0 \text{ V}$</td>
<td>$3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$-8 \mu A$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCA}$ or GND, $I_O = 0 \text{ mA}$</td>
<td>$3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCB}$ or GND, $I_O = 0 \text{ mA}$</td>
<td>$3.6 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$-8 \mu A$</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$C_I$ Input</td>
<td>$V_I = 1.65 \text{ V DC} + 1\text{MHz} -16 \text{dBm sine wave}$</td>
<td>$3.3 \text{ V}$</td>
<td>$0 \text{ V}$</td>
<td>$2 \text{ pF}$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$C_O$ Output</td>
<td>$V_I = 1.65 \text{ V DC} + 1\text{MHz} -16 \text{dBm sine wave}$</td>
<td>$0 \text{ V}$</td>
<td>$3.3 \text{ V}$</td>
<td>$4 \text{ pF}$</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

(1) All typical values are for $T_A = 25°C$

6.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>$V_{CCA}$</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$I_{PD}$ Propagation Delay</td>
<td>$V_{CCA} = 1.80 \pm 0.15 \text{ V}$</td>
<td>$V_{CCB} = 1.80 \pm 0.15 \text{ V}$</td>
<td>$0.5$</td>
<td>$20$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 2.50 \pm 0.20 \text{ V}$</td>
<td>$0.5$</td>
<td>$17$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 3.30 \pm 0.30 \text{ V}$</td>
<td>$0.5$</td>
<td>$14$</td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCA} = 2.50 \pm 0.20 \text{ V}$</td>
<td>$V_{CCB} = 1.80 \pm 0.15 \text{ V}$</td>
<td>$0.5$</td>
<td>$18$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 2.50 \pm 0.20 \text{ V}$</td>
<td>$0.5$</td>
<td>$15$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 3.30 \pm 0.30 \text{ V}$</td>
<td>$0.5$</td>
<td>$12$</td>
<td></td>
</tr>
<tr>
<td></td>
<td>$V_{CCA} = 3.30 \pm 0.30 \text{ V}$</td>
<td>$V_{CCB} = 1.80 \pm 0.15 \text{ V}$</td>
<td>$0.5$</td>
<td>$16$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 2.50 \pm 0.20 \text{ V}$</td>
<td>$0.5$</td>
<td>$13$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCB} = 3.30 \pm 0.30 \text{ V}$</td>
<td>$0.5$</td>
<td>$10$</td>
<td></td>
</tr>
</tbody>
</table>

6.7 Operating Characteristics

$T_A = 25°C$

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>$V_{CCA}$</th>
<th>$V_{CCB}$</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$C_{pdA}$ Power dissipation capacitance - Port A</td>
<td>$I_O = 0 \text{ mA}$</td>
<td>$C_L = 0 \text{ pF}$, $f = 1 \text{ MHz}$, $t_r = t_f = 1 \text{ ns}$</td>
<td>$V_{CCA} = V_{CCB} = 1.8 \text{ V}$</td>
<td>$1$</td>
<td>$\text{pF}$</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCA} = V_{CCB} = 2.5 \text{ V}$</td>
<td>$1.3$</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCA} = V_{CCB} = 3.3 \text{ V}$</td>
<td>$1.8$</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$C_{pdB}$ Power dissipation capacitance - B Port</td>
<td>$I_O = 0 \text{ mA}$</td>
<td>$C_L = 0 \text{ pF}$, $f = 1 \text{ MHz}$, $t_r = t_f = 1 \text{ ns}$</td>
<td>$V_{CCA} = V_{CCB} = 1.8 \text{ V}$</td>
<td>$12$</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCA} = V_{CCB} = 2.5 \text{ V}$</td>
<td>$15$</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$V_{CCA} = V_{CCB} = 3.3 \text{ V}$</td>
<td>$18$</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>
6.8 Typical Characteristics

**Figure 1.** $V_{OH}$ vs. $I_{OH}$, 1.8 V

**Figure 2.** $V_{OL}$ vs. $I_{OL}$, 1.8 V

**Figure 3.** $V_{OH}$ vs. $I_{OH}$, 2.5 V

**Figure 4.** $V_{OL}$ vs. $I_{OL}$, 2.5 V

**Figure 5.** $V_{OH}$ vs. $I_{OH}$, 3.3 V

**Figure 6.** $V_{OL}$ vs. $I_{OL}$, 3.3 V
7 Parameter Measurement Information

7.1 Load Circuit and Voltage Waveforms

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- \( f = 1 \text{ MHz} \)
- \( Z_0 = 50 \text{ } \Omega \)
- \( \frac{dv}{dt} \leq 1 \text{ ns/V} \)

(1) \( C_L \) includes probe and jig capacitance.

![Figure 7. Load Circuit](image)

Table 1. Load Circuit Conditions

<table>
<thead>
<tr>
<th>Parameter</th>
<th>( V_{CC} )</th>
<th>( R_L )</th>
<th>( C_L )</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{pd} )</td>
<td>Propagation (delay) time</td>
<td>1.65 V – 3.6 V</td>
<td>2 kΩ</td>
</tr>
</tbody>
</table>

(1) \( V_{CCI} \) is the supply pin associated with the input port.

(2) \( V_{OH} \) and \( V_{OL} \) are typical output voltage levels that occur with specified \( R_L \) and \( C_L \).

![Figure 8. Propagation Delay](image)
8 Detailed Description

8.1 Overview
The 2N7001T is a single-bit dual-supply buffered voltage signal converter that can be used to up or down-translate a single unidirectional signal. The device is operational with both \( V_{CCA} \) and \( V_{CCB} \) supplies down to 1.65 V and up to 3.60 V. \( V_{CCA} \) defines the input threshold voltage on the A input while \( V_{CCB} \) defines the output voltage on the B output.

8.2 Functional Block Diagram

8.3 Feature Description

8.3.1 Up-Translation or Down-Translation from 1.65 V to 3.60 V
The \( V_{CCA} \) and \( V_{CCB} \) pins can both be supplied by a voltage range from 1.65 V to 3.6 V. This voltage range makes the device suitable for translating between any of the voltage nodes (1.8 V, 2.5 V, and 3.3 V).

8.3.2 Balanced CMOS Push-Pull Outputs
A balanced output allows the device to sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the Absolute Maximum Ratings must be followed at all times.

8.3.3 Standard CMOS Inputs
Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance shown in the Electrical Characteristics. The worst case resistance is calculated with the maximum input voltage, shown in the Absolute Maximum Ratings, and the maximum input leakage current, shown in the Electrical Characteristics, using Ohm's law \( R = \frac{V}{I} \).

Signals applied to the inputs need to have fast edge rates, as defined by \( \Delta t/\Delta v \) in the Recommended Operating Conditions to avoid excessive current consumption and oscillations. If a slow or noisy input signal is required, a device with a Schmitt-trigger input should be used to condition the input signal prior to the standard CMOS input.
Feature Description (continued)

8.3.4 Negative Clamping Diodes

The inputs and outputs to this device have negative clamping diodes as shown in Figure 9.

**CAUTION**

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

![Figure 9. Electrical Placement of Clamping Diodes for Each Input and Output](image)

8.3.5 Partial Power Down (I\text{off})

The inputs and outputs for this device enter a high-impedance state when the supply voltage is 0 V. The maximum leakage into or out of any input pin or output pin on the device is specified by I\text{off} in the *Electrical Characteristics*.

8.3.6 Over-voltage Tolerant Inputs

Input signals to this device can be driven above the input supply voltage (V\text{CCA}), as long as they remain below the maximum input voltage value specified in the *Recommended Operating Conditions*.

8.4 Device Functional Modes

Table 2 lists the functional modes of the 2N7001T device.

<table>
<thead>
<tr>
<th>INPUT</th>
<th>OUTPUT</th>
</tr>
</thead>
<tbody>
<tr>
<td>L (Referenced to V\text{CCA})</td>
<td>L (Referenced to V\text{CBB})</td>
</tr>
<tr>
<td>H (Referenced to V\text{CCA})</td>
<td>H (Referenced to V\text{CBB})</td>
</tr>
</tbody>
</table>
9 Application and Implementation

NOTE
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information
The 2N7001T device can be used in level-translation applications for interfacing between devices or systems that are operating at different interface voltages.

9.2 Typical Applications

9.2.1 Processor Error Up Translation
Figure 10 shows an example of the 2N7001T being used in a unidirectional logic level-shifting application.

9.2.1.1 Design Requirements
For this design example, use the parameters shown in Table 3.

Table 3. Design Parameters

<table>
<thead>
<tr>
<th>DESIGN PARAMETER</th>
<th>EXAMPLE VALUE</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input voltage supply</td>
<td>1.8 V</td>
</tr>
<tr>
<td>Output voltage supply</td>
<td>3.3 V</td>
</tr>
</tbody>
</table>

9.2.1.2 Detailed Design Procedure
To begin the design process, determine the following:

- Input voltage range
  - The supply voltage of the upstream device (device that is driving input pin A) will determine the appropriate input voltage range. For a valid logic-high, the value must exceed the high-level input voltage (V_{IH}) of the input port. For a valid logic low the value must be less than the low-level input voltage (V_{IL}) of the input port.
- Output voltage range
  - The supply voltage of the downstream device (device that output pin B is driving) will determine the appropriate output voltage range.
9.2.1.3 Application Curve

![Application Curve Diagram](image)

**Figure 11.** Up Translation (1.8 V to 3.3 V) at 1 MHz

9.2.2 Discrete FET Translation Replacement

The 2N7001T device is an excellent option for replacing discrete translators, as shown in Figure 12, and has the following benefits regarding discrete translation implementations:

- A single device vs a four component solution
- Minimized implementation size
- Lower power consumption
- \( V_{CC} \) isolation feature
- Higher data rates
- Integrated ESD protection
- Improved glitch performance

**Figure 12.** Discrete Translation vs. 2N7001T Solution

Discrete Translator: Four Component, Push-Pull Translation w/o ESD Protection

| 603 Res. | SOT23 FET | SOT23 FET | Solution Size: ~ 60mm² |

2N7001T: Single Small Footprint Device, Low Power Translation with ESD Protection

- **DPW Package**
  - Solution Size: 0.64mm²
- **DCK Package**
  - Solution Size: 4.2mm²
10 Power Supply Recommendations

The 2N7001T device uses two separate configurable power-supply rails, $V_{CCA}$ and $V_{CCB}$. The $V_{CCA}$ and $V_{CCB}$ power-supply rails accept any supply voltage that range from 1.65 V to 3.6 V. The A input and B output are referenced to $V_{CCA}$ and $V_{CCB}$ respectively allowing up or down translation among the 1.8-V, 2.5-V, and 3.3-V voltage nodes. A 0.1 µF bypass capacitor is recommended on all $V_{CC}$ pins.

Always apply a ground reference to the GND pin first. However, there are no additional requirement for power supply sequencing.

11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, follow the common printed-circuit board layout guidelines listed below:

• Use bypass capacitors on power supplies.
• Use short trace lengths to avoid excessive loading.

An example layout is given in Figure 13 for the DPW (X2SON-5) package. This example layout includes two 0402 (metric) capacitors, and uses the measurements that are in the package outline drawing appended to the end of this datasheet. A via of diameter 0.1 mm (3.973 mil) is placed directly in the center of the device. This via can be used to trace out the center pin connection through another board layer, or the via can be left out of the layout.

11.2 Layout Example

![Figure 13. Example Layout for the DPW (X2SON-5) Package](image-url)
12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation
For related documentation see the following:
• Texas Instruments, *Implications of Slow or Floating CMOS Inputs* application report
• Texas Instruments, *Designing and Manufacturing with TI's X2SON Packages* application report

12.2 Receiving Notification of Documentation Updates
To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Community Resources
The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks
E2E is a trademark of Texas Instruments.

12.5 Electrostatic Discharge Caution
This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary
*SLYZ022 — TI Glossary.*
This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
## PACKAGING INFORMATION

<table>
<thead>
<tr>
<th>Orderable Device</th>
<th>Status (1)</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan (2)</th>
<th>Lead/Ball Finish</th>
<th>MSL Peak Temp (3)</th>
<th>Op Temp (°C)</th>
<th>Device Marking (4/5)</th>
<th>Samples</th>
</tr>
</thead>
<tbody>
<tr>
<td>2N7001TDCKR</td>
<td>ACTIVE</td>
<td>SC70</td>
<td>DCK</td>
<td>5</td>
<td>3000</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU SN</td>
<td>Level-1-260C-UNLIM</td>
<td>-40 to 125</td>
<td>DQ</td>
<td>Samples</td>
</tr>
<tr>
<td>2N7001TDPWR</td>
<td>ACTIVE</td>
<td>X2SON</td>
<td>DPW</td>
<td>5</td>
<td>3000</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU NIPDAUAG</td>
<td>Level-1-260C-UNLIM</td>
<td>-40 to 125</td>
<td>DP</td>
<td>Samples</td>
</tr>
</tbody>
</table>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) **MSL, Peak Temp.** - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) **Lead/Ball Finish** - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.
## TAPE AND REEL INFORMATION

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Reel Diameter (mm)</th>
<th>Reel Width W1 (mm)</th>
<th>A0 (mm)</th>
<th>B0 (mm)</th>
<th>K0 (mm)</th>
<th>P1 (mm)</th>
<th>W (mm)</th>
<th>Pin 1 Quadrant</th>
</tr>
</thead>
<tbody>
<tr>
<td>2N7001TDCKR</td>
<td>SC70</td>
<td>DCK</td>
<td>5</td>
<td>3000</td>
<td>178.0</td>
<td>9.0</td>
<td>2.4</td>
<td>2.5</td>
<td>1.2</td>
<td>4.0</td>
<td>8.0</td>
<td>Q3</td>
</tr>
<tr>
<td>2N7001TDPW</td>
<td>X2SON</td>
<td>DPW</td>
<td>5</td>
<td>3000</td>
<td>178.0</td>
<td>8.4</td>
<td>0.91</td>
<td>0.91</td>
<td>0.5</td>
<td>2.0</td>
<td>8.0</td>
<td>Q3</td>
</tr>
</tbody>
</table>

*All dimensions are nominal.*

---

**Notes:**
- **Device**: Type of semiconductor device.
- **Package Type**: The type of package used.
- **Package Drawing**: Drawing reference for the package.
- **Pins**: Number of pins on the device.
- **SPQ**: Specification Product Quality level.
- **Reel Diameter (mm)**: Diameter of the reel in millimeters.
- **Reel Width W1 (mm)**: Width of the reel in millimeters.
- **A0 (mm)**: Dimension designed to accommodate the component width.
- **B0 (mm)**: Dimension designed to accommodate the component length.
- **K0 (mm)**: Dimension designed to accommodate the component thickness.
- **W (mm)**: Overall width of the carrier tape.
- **P1 (mm)**: Pitch between successive cavity centers.
- **User Direction of Feed**: Direction in which the tape is fed.
- **Pocket Quadrants**: Quadrants where the tape is pocketed.
- **Sprocket Holes**: Holes for sprockets on the tape.

---

*All dimensions are nominal.*
### TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal*

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Length (mm)</th>
<th>Width (mm)</th>
<th>Height (mm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>2N7001TDCKR</td>
<td>SC70</td>
<td>DCK</td>
<td>5</td>
<td>3000</td>
<td>180.0</td>
<td>180.0</td>
<td>18.0</td>
</tr>
<tr>
<td>2N7001TDPWR</td>
<td>X2SON</td>
<td>DPW</td>
<td>5</td>
<td>3000</td>
<td>205.0</td>
<td>200.0</td>
<td>33.0</td>
</tr>
</tbody>
</table>
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The size and shape of this feature may vary.
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 (www.ti.com/lit/slua271).
5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
MECHANICAL DATA

DCK (R-PDSO-G5)  PLASTIC SMALL-OUTLINE PACKAGE

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
D. Falls within JEDEC MO-203 variation AA.

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NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
D. Publication IPC-7351 is recommended for alternate designs.
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
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